## Sheet 1 of 1

Form P (4-18) (Rev. 8-83)	AC ELE	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. 13347US02		SERIAL NO. 09/986,226	
		INFORMATION DISC	APPLICANT(s): Whittingham et al.						
(Use several sheets if necessary)						FILING DATE 10/22/01		GROUP ART UNIT: <del>2622</del> 2854	
			U.S.	PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	(	CLASS	SUBCLAS	FILING DATE IF APPROPRIATI	
36	Α	5,227,643	07-13-93	Craig et al.	а	<u>გ</u> 5	460.15		
1	В	5,239,622	08-24-93	Best et al.	3	58	1.18		
	С	5,287,434	02-15-94	Bain et al.	a	<b>ව</b> ති	462.15		
	٥	5,345,091	09-06-94	Craig et al.	9	<b>3</b> 5	462.15		
	ш	5,621,864	04-15-97	Benade et al.	3	58	1.18		
	F	5,930,810	07-27-99	Farros et al	7	15	506		
	G	6,018,338	01-25-00	Greulich et al.		15	883		
	H	US-2002/0030854	03-14-02	Schutz et al.		<i>9</i> 8	(.18		
		US-2002/0154338	10-24-02	Tanaka		58	1.18		
34	J	US-2003/0004946	01-02-03	VanDenAvond et al.		701	9		
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## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL			T			T	TRANSLATION	
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
රුව	N	WO 01/55869 A1	01-23-01	PCT		_		
38	0	WO 01/66349 A1	03-02-01	PCT				
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## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER Chaples Evani	plie	DATE CONSIDERED: 09/16/05
*EXAMINER: Initial citation considered, v	whether or not citation is in conformance with f	MPEP 609; Draw line through citation if not in conformance and
not considered. Include copy of this form	with next communication to applicant.	•